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| IEEE STD | IEEE Standard              |

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| <input type="checkbox"/> | <p>4. <b>Analysis of crosstalk coupling effects between aggressor and victim interconnect using two</b><br/>         Palit, A.K.; Meyer, V.; Anheier, W.; Schloeffel, J.;<br/>         Signal Propagation on Interconnects, 2004. Proceedings. 8th IEEE Workshop on<br/>         9-12 May 2004 Page(s):81 - 84<br/>         Digital Object Identifier 10.1109/SPI.2004.1409011<br/> <a href="#">AbstractPlus</a>   Full Text: <a href="#">PDF</a>(618 KB) IEEE CNF</p> |
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| <input type="checkbox"/> | <p>6. <b>Analysis of noise avoidance techniques in DSM interconnects using a complete crosstalk n</b><br/>         Becer, M.R.; Blaauw, D.; Zolotov, V.; Panda, R.; Hajj, I.N.;<br/>         Design, Automation and Test in Europe Conference and Exhibition, 2002. Proceedings</p>  |

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